

Applicant: Peter de Groot

Art Unit : Unknown

Serial No.: 10/025,595

Examiner: Unknown

Filed

: December 18, 2001

Title

OPTICAL SURFACE PROFILING SYSTEMS

Commissioner for Patents Washington, D.C. 20231

INFORMATION DISCLOSURE STATEMENT

Applicant submits the references listed on the attached form PTO-1449, copies of which are enclosed.

This statement is being filed before the receipt of a first Office action on the merits. Please apply any charges or credits to Deposit Account No. 06-1050.

Respectfully submitted,

March 22, 2002

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I hereby certify under 37 CFR §1.8(a) that this correspondence is being deposited with the United States Postal Service as first class mail with sufficient postage on the date indicated below and is addressed to the Commissioner for Patents, Washington, D.C. 20231.

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Sheet	1	of	1	

Substitute Form PTO-1449 (Modified)

9 U.S. partment of Commerce

Attorney's Docket No. 09712-055001

Application No. 10/025,595

Information Disclosure Statement

Applicant
Peter de Groot

Filing Date

December 18, 2001

Group Art Unit

(37 CFR §1.98(b))

U.S. Patent Documents							
Examiner Initial	Desig. ID	Patent Number	Issue Date	Patentee	Class	Subclass	Filing Date If Appropriate
• • • • • • • • • • • • • • • • • • • •	AA	4,340,306	07/20/82	Balasubramanian			
	AB	4,869,593	09/26/89	Biegen			
	AC	5,239,178	08/24/93	Derndinger et al.			
	AD	5,398,113	03/14/95	de Groot			
	AE	5,737,084	04/07/98	Ishihara			

Foreign Patent Documents or Published Foreign Patent Applications							
Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation Yes No
	AF						

	Other Documents (include Author, Title, Date, and Place of Publication)				
Examiner Initial	Desig. ID	Document			
,	AG	Caber, Paul J., "Interferometric Profiler for Rough Surfaces", Applied Optics, Vol. 32, No. 19, July 1, 1993, pp. 3438-3441			
	АН	Dresel, Thomas et al., "Three-dimensional sensing of rough surfaces by coherence radar", Applied Optics, Vol. 31, No. 7, March 1, 1992, pp. 919-925			
	AI	Tiziani H.J. et al., "Chromatic confocal microscopy with microlenses", <i>Journal of Modern Optics</i> , Vol. 43, No. 1, 1996, pp. 155-163			
	AJ	Tiziani H.J. et al., "Three-dimensional analysis by a microlens-array confocal arrangement", <i>Applied Optics</i> , Vol. 33, No. 4, February 1, 1994, pp. 567-572			

Examiner Signature

Date Considered

EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.